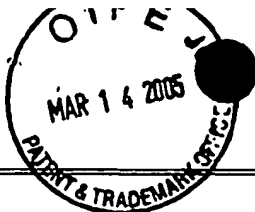
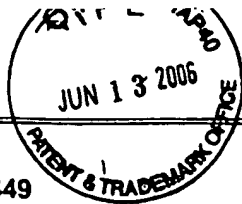


<b>FORM PTO-1449</b>  <b>INFORMATION DISCLOSURE STATEMENT</b>		<b>Docket No.:</b> <b>MFR 126NP</b>		<b>International No.:</b> <b>PCT/DE03/02224</b> <b>10/519383</b>		
		<b>Applicant:</b> <b>Elisabeth Katz</b>				
		<b>International Filing Date:</b> <b>July 3, 2003</b>		<b>Group Art Unit:</b> <del>To Be Assigned</del> 2882		
<b>U.S. PATENT DOCUMENTS</b>						
Ex- am- iner Ini- tial	Document Number	Date	Name	Class	Sub- Class	Filing Date
CK	5,497,008	03/05/96	Kumakhov			
CK	5,778,039	07/7/98	Hossain et al.			
<b>FOREIGN PATENT DOCUMENTS</b>						
	Document Number	Date	Country	Class	Sub- Class	Trans- lation
<b>OTHER (Including Author, Title, Date, Pertinent Pages, etc.)</b>						
CK	Nikitina S V et al. : "X-Ray Fluorescence analysis on the Base of Polycapillary Kumakhov Optics" Review of scientific Instruments, American Institute of Physics. New York, US, Vol. 70, No. 7, July 1999, pages 2950-2956, XP000875412. ISSN: 0034-6748					
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Examiner /Chih-Cheng Kao/				Date Considered 08/24/2006		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.						



<b>FORM PTO-1449</b> <b>INFORMATION DISCLOSURE STATEMENT</b>				Atty. Docket  MFR 126		Application No.  10/519,383	
				Applicant Elisabeth KATZ			
				Filing Date December 27, 2004		Group <del>To Be Assigned</del> 2882	
<b>U.S. PATENT DOCUMENTS</b>							
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CK	AA	6,233,306 B1	05/15/2001	Van Sprang			
CK	AB	5,721,759	02/24/1998	Raatikainen			
	AC						
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		Document Number	Date	Country	Class	Sub-Class	Translation
CK	AI	EP 1 202 045 A1	05/02/2002	EUROPE			N/A
CK	AJ	EP 0 985 926 A2	03/15/2000	EUROPE			No (Statement of Relevance is in the IDS)
CK	AK	WO 00/16078	03/23/00	WIPO			N/A
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	AM						
	AN						
<b>OTHER (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
CK	AO	An English-language Abstract of the Japanese patent publication No. 11132970 A (05/21/1999).					
Examiner /Chih-Cheng Kao/					Date Considered 08/24/2006		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							



<b>FORM PTO-1449</b> <b>INFORMATION DISCLOSURE STATEMENT</b>	Atty. Docket  MFR 126	Application No.  10/519,383
	Applicant Elisabeth KATZ	
	Filing Date December 27, 2004	Group Art Unit 2882

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**OTHER (Including Author, Title, Date, Pertinent Pages, etc.)**

<del>AO</del>	<del>An English language Abstract of the Japanese patent publication No. 11482673 A (95/24/1999).</del>
Examiner /Chih-Cheng Kao/	Date Considered 08/24/2006

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.